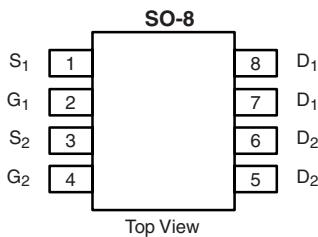


N- and P-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY

	V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A) ^a	Q_g (Typ.)
N-Channel	40	0.016 at $V_{GS} = 10$ V	8	56
		0.019 at $V_{GS} = 4.5$ V	8	
P-Channel	- 40	0.025 at $V_{GS} = - 10$ V	- 8	6
		0.032 at $V_{GS} = - 4.5$ V	- 7.5	



Ordering Information: Si4563DY-T1-E3 (Lead (Pb)-free)
Si4563DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

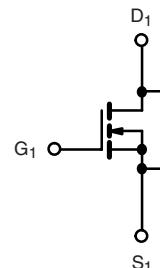
- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET® Power MOSFET
- 100 % R_g Tested



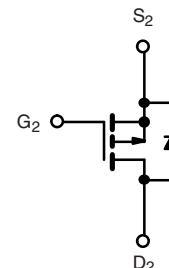
RoHS
COMPLIANT
HALOGEN
FREE
Available

APPLICATIONS

- CCFL Inverter



N-Channel MOSFET



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted

Parameter	Symbol	N-Channel	P-Channel	Unit
Drain-Source Voltage	V_{DS}	40	- 40	V
Gate-Source Voltage	V_{GS}		± 16	
Continuous Drain Current ($T_J = 150$ °C)	I_D	8	- 8	
		8	- 6.5	
		8 ^{b, c}	- 6.6 ^{b, c}	
		6.5 ^{b, c}	- 5.2 ^{b, c}	
Pulsed Drain Current (10 μ s Pulse Width)	I_{DM}	20	- 20	A
Source-Drain Current Diode Current	I_S	2.7	- 2.7	
		1.6 ^{b, c}	- 1.6 ^{b, c}	
Pulsed Source-Drain Current	I_{SM}	20	- 20	
Single Pulse Avalanche Current	I_{AS}	20	25	mJ
Single Pulse Avalanche Energy	E_{AS}	20	31.2	
Maximum Power Dissipation	P_D	3.25	3.25	
		2.10	2.10	
		2.0 ^{b, c}	2.0 ^{b, c}	
		1.25 ^{b, c}	1.25 ^{b, c}	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to 150		°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	N-Channel		P-Channel		Unit
		Typ.	Max.	Typ.	Max.	
Maximum Junction-to-Ambient ^{b, d}	R_{thJA}	45	62.5	45	62.5	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	29	38	29	38

Notes:

a. Based on $T_C = 25$ °C.

b. Surface Mounted on 1" x 1" FR4 board.

c. $t = 10$ s.

d. Maximum under Steady State conditions is 120 °C/W.

SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Test Conditions		Min.	Typ. ^a	Max.	Unit	
Static								
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	N-Ch	40			V	
		$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	P-Ch	-40				
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250 \mu\text{A}$	N-Ch		40		mV/ $^\circ\text{C}$	
		$I_D = -250 \mu\text{A}$	P-Ch		-40			
$V_{GS(\text{th})}$ Temperature Coefficient	$\Delta V_{GS(\text{th})}/T_J$	$I_D = 250 \mu\text{A}$	N-Ch		-4.8			
		$I_D = -250 \mu\text{A}$	P-Ch		4.0			
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	N-Ch	0.8		2.0	V	
		$V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$	P-Ch	-0.8		-2.2		
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 16 \text{ V}$	N-Ch			100	nA	
			P-Ch			-100		
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$	N-Ch			1	μA	
		$V_{DS} = -40 \text{ V}, V_{GS} = 0 \text{ V}$	P-Ch			-1		
		$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55^\circ\text{C}$	N-Ch			10		
		$V_{DS} = -40 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 55^\circ\text{C}$	P-Ch			-10		
On-State Drain Current ^b	$I_{D(on)}$	$V_{DS} = 5 \text{ V}, V_{GS} = 10 \text{ V}$	N-Ch	20			A	
		$V_{DS} = -5 \text{ V}, V_{GS} = -10 \text{ V}$	P-Ch	-20				
Drain-Source On-State Resistance ^b	$R_{DS(on)}$	$V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	N-Ch		0.013	0.016	Ω	
		$V_{GS} = -10 \text{ V}, I_D = -5 \text{ A}$	P-Ch		0.020	0.025		
		$V_{GS} = 4.5 \text{ V}, I_D = 4 \text{ A}$	N-Ch		0.015	0.019		
		$V_{GS} = -4.5 \text{ V}, I_D = -4 \text{ A}$	P-Ch		0.025	0.032		
Forward Transconductance ^b	g_{fs}	$V_{DS} = 15 \text{ V}, I_D = 5 \text{ A}$	N-Ch		23		S	
		$V_{DS} = -15 \text{ V}, I_D = -5 \text{ A}$	P-Ch		18			
Dynamic^a								
Input Capacitance	C_{iss}	N-Channel $V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	N-Ch		2390		pF	
			P-Ch		2120			
Output Capacitance	C_{oss}		N-Ch		270			
			P-Ch		310			
Reverse Transfer Capacitance	C_{rss}		N-Ch		165			
			P-Ch		235			
Total Gate Charge	Q_g	N-Channel $V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	N-Ch		56	85	nC	
			P-Ch		52	80		
Gate-Source Charge	Q_{gs}		N-Ch		26	40		
			P-Ch		25.5	39		
Gate-Drain Charge	Q_{gd}	P-Channel $V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	N-Ch		5.5			
			P-Ch		5.1			
Gate Resistance	R_g		N-Ch		9.7			
			P-Ch		11.7			
		$f = 1 \text{ MHz}$	N-Ch		2.6	4.0	Ω	
			P-Ch		5.8	9.0		

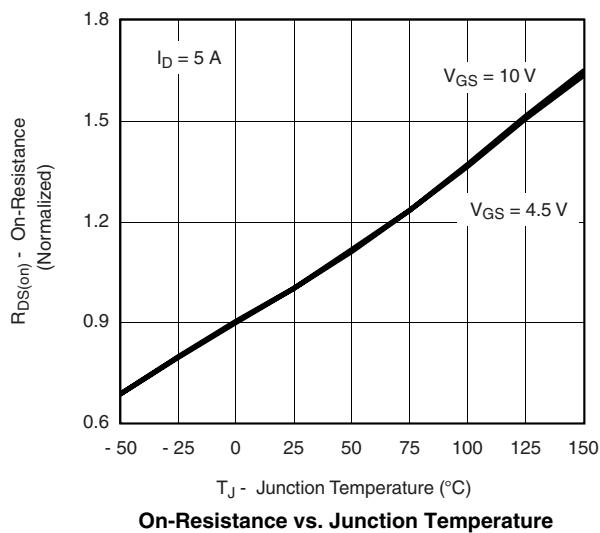
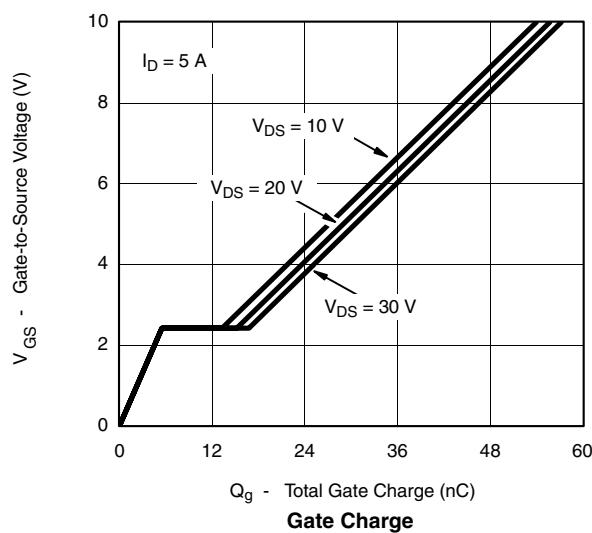
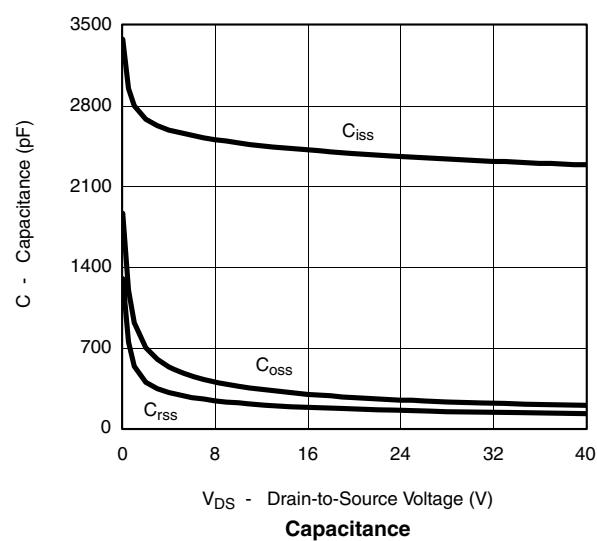
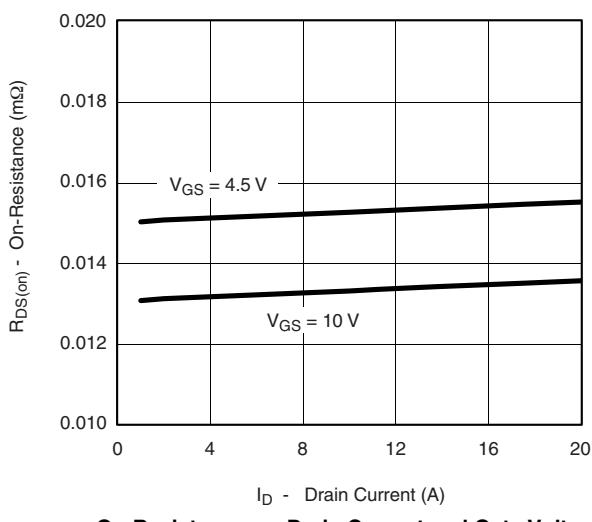
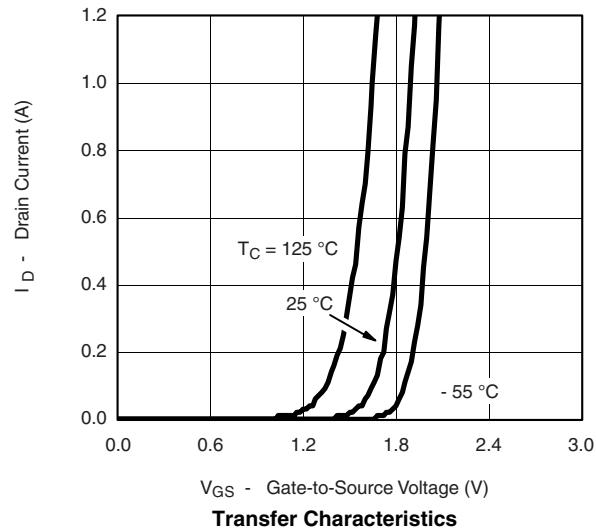
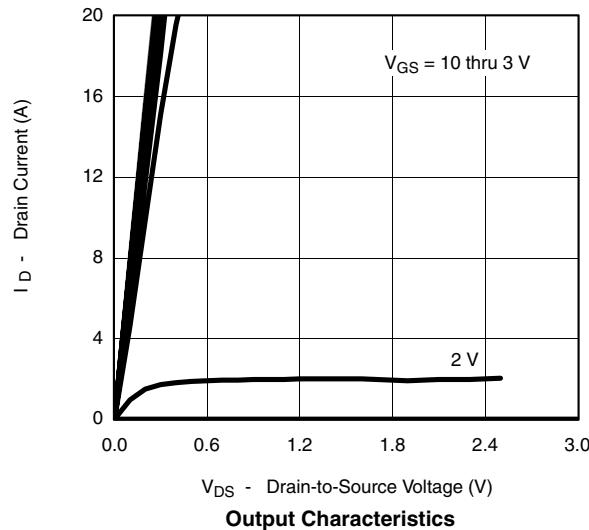
SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted								
Parameter	Symbol	Test Conditions			Min.	Typ. ^a	Max.	Unit
Dynamic^a								
Turn-On Delay Time	$t_{d(on)}$	N-Channel $V_{DD} = 20 \text{ V}$, $R_L = 4 \Omega$ $I_D \geq 5 \text{ A}$, $V_{GEN} = 10 \text{ V}$, $R_g = 1 \Omega$	N-Ch		15	23		ns
Rise Time	t_r		P-Ch		13	20		
Turn-Off Delay Time	$t_{d(off)}$		N-Ch		20	30		
Fall Time	t_f		P-Ch		16	25		
Turn-On Delay Time	$t_{d(on)}$		N-Ch		56	85		
Rise Time	t_r		P-Ch		75	115		
Turn-Off Delay Time	$t_{d(off)}$		N-Ch		10	15		
Fall Time	t_f		P-Ch		68	105		
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	I_S	$T_C = 25^\circ\text{C}$	N-Ch			2.7		A
Pulse Diode Forward Current ^a	I_{SM}		P-Ch			- 2.7		
Body Diode Voltage	V_{SD}	$I_S = 1.5 \text{ A}$	N-Ch		0.69	1.2		V
Body Diode Reverse Recovery Time	t_{rr}	$I_S = - 1.6 \text{ A}$	P-Ch		- 0.72	- 1.2		
Body Diode Reverse Recovery Charge	Q_{rr}	N-Channel $I_F = 2 \text{ A}$, $dI/dt = 100 \text{ A}/\mu\text{s}$, $T_J = 25^\circ\text{C}$	N-Ch		62	95		ns
Reverse Recovery Fall Time	t_a		P-Ch		49	75		
Reverse Recovery Rise Time	t_b		N-Ch		62	95		nC
			P-Ch		42	65		
			N-Ch		26			ns
			P-Ch		19			
			N-Ch		36			ns
			P-Ch		30			

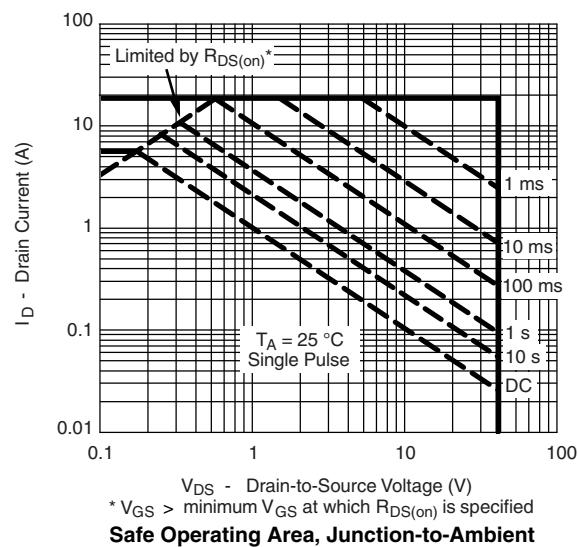
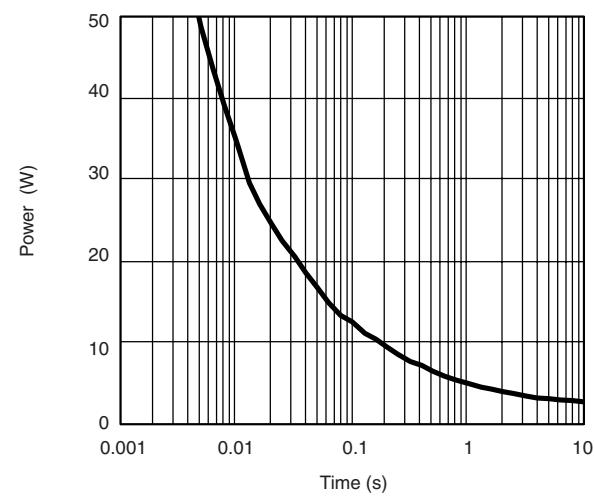
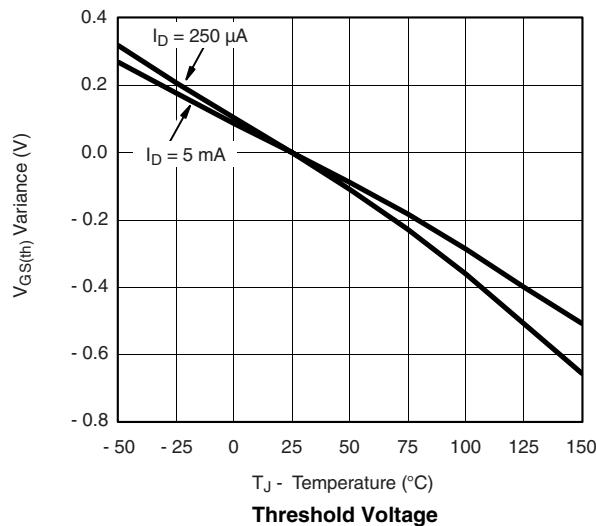
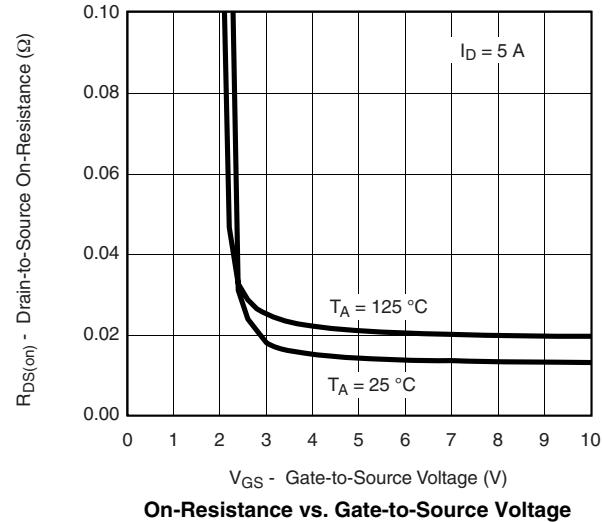
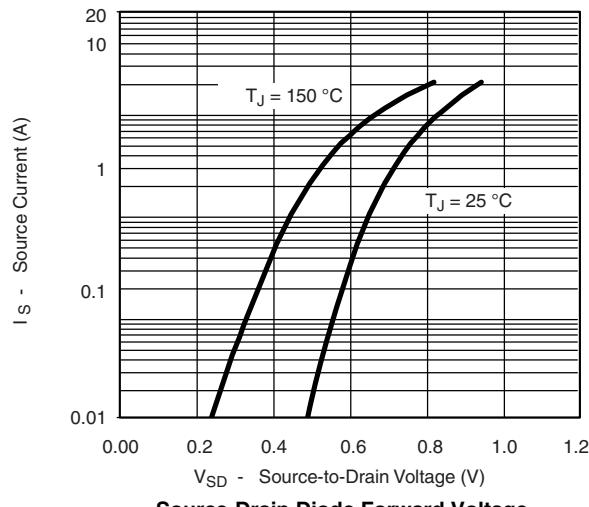
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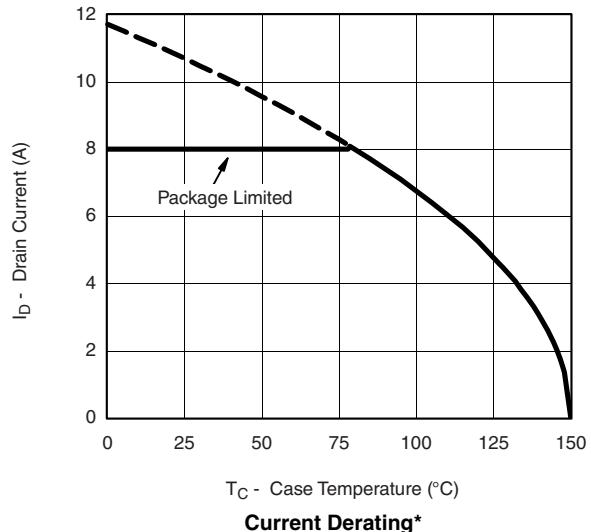
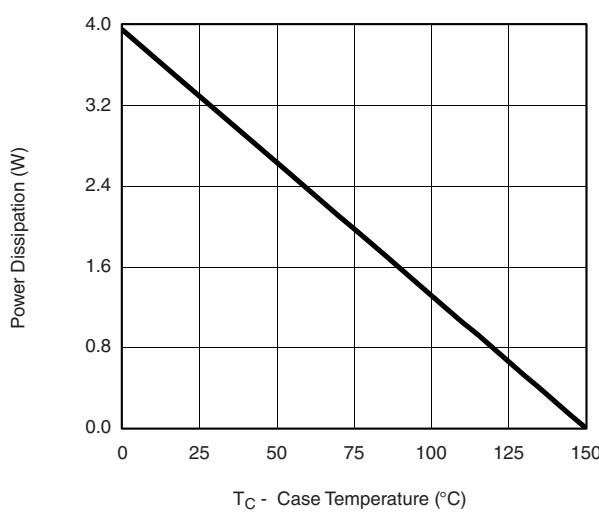
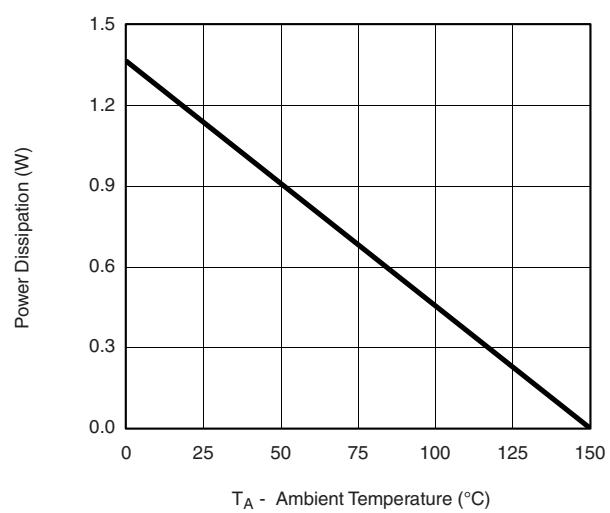
- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

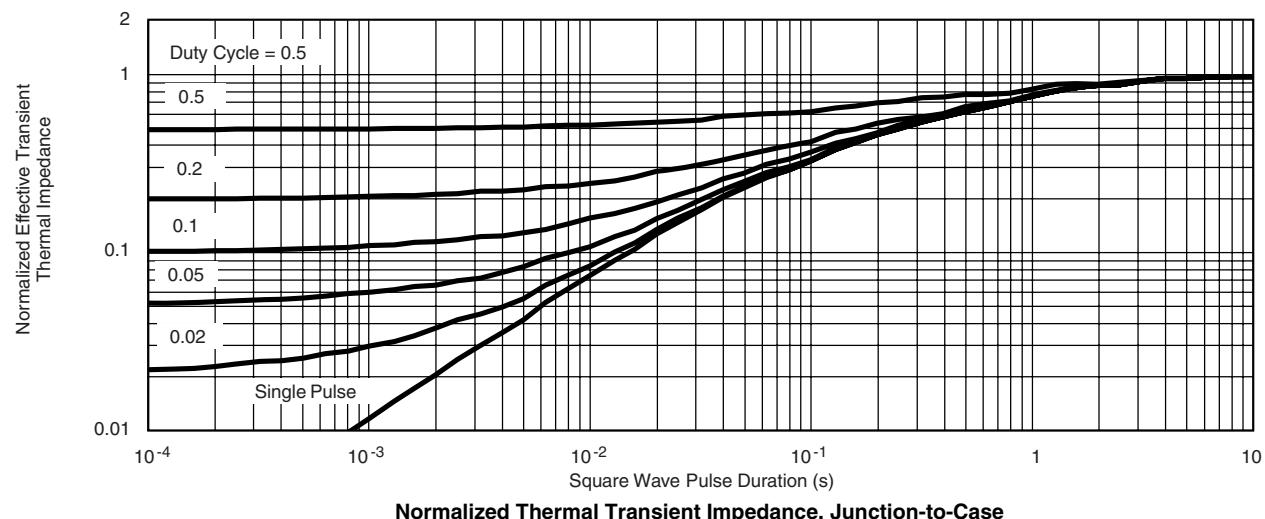
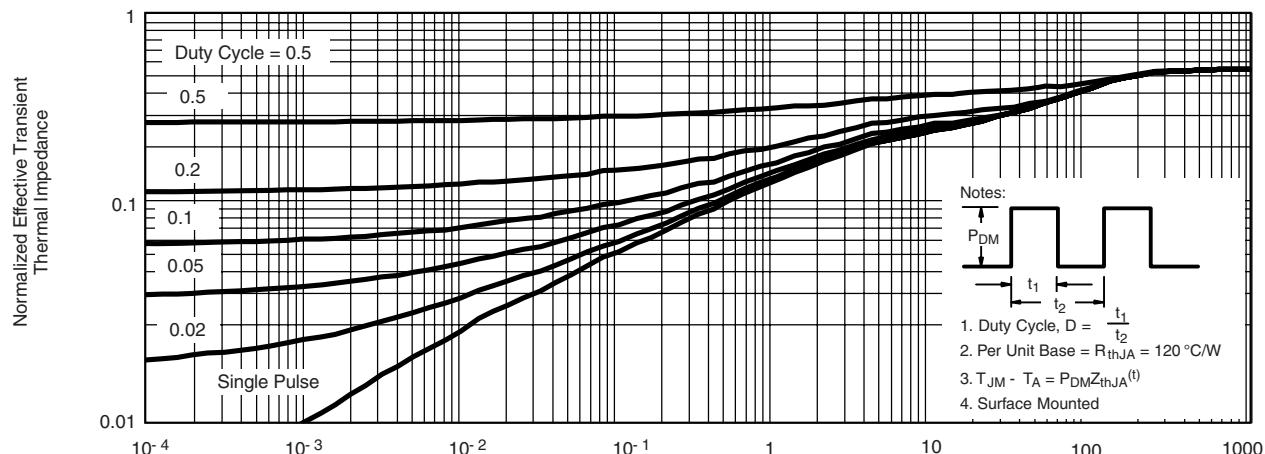
N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



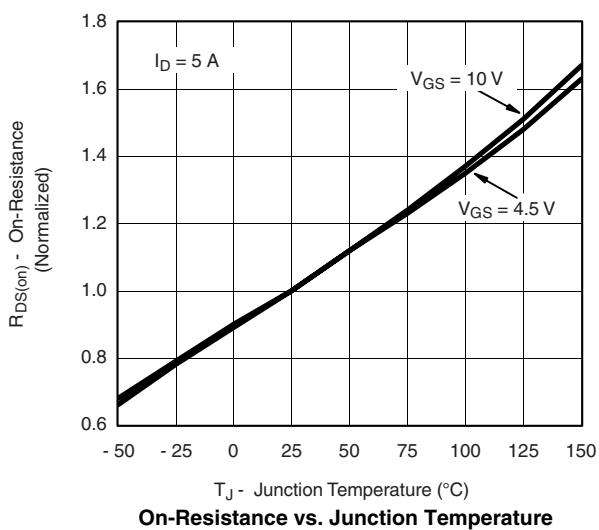
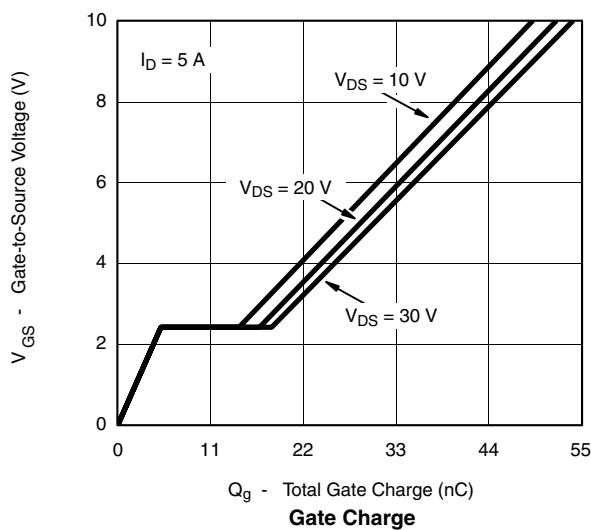
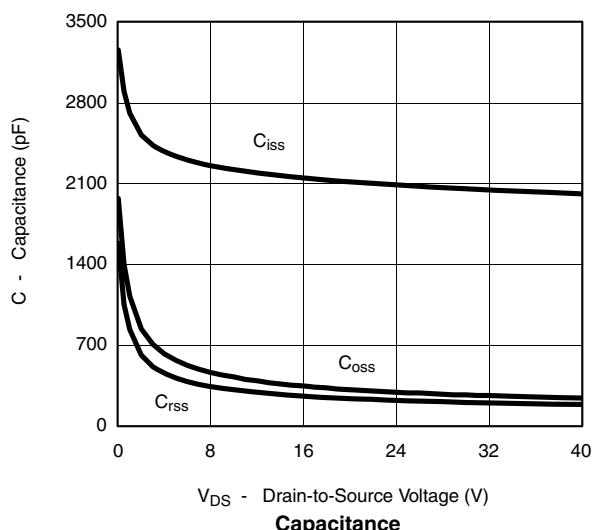
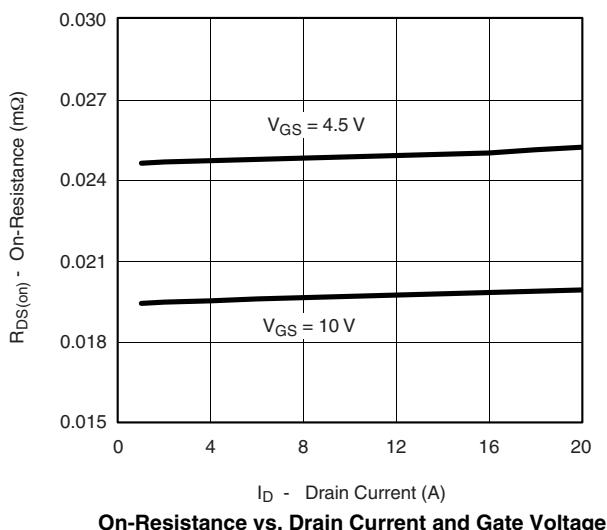
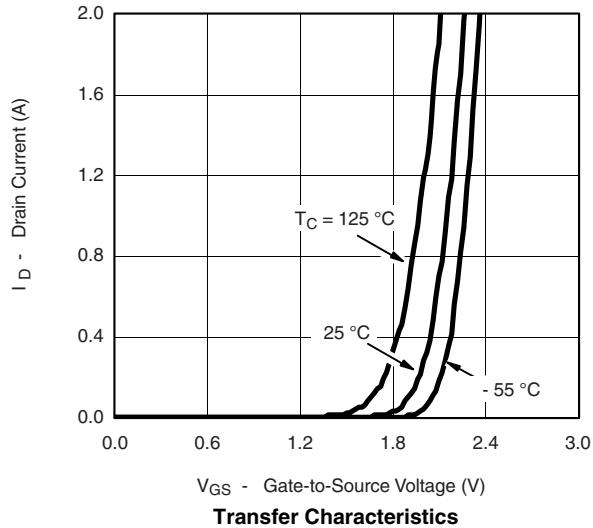
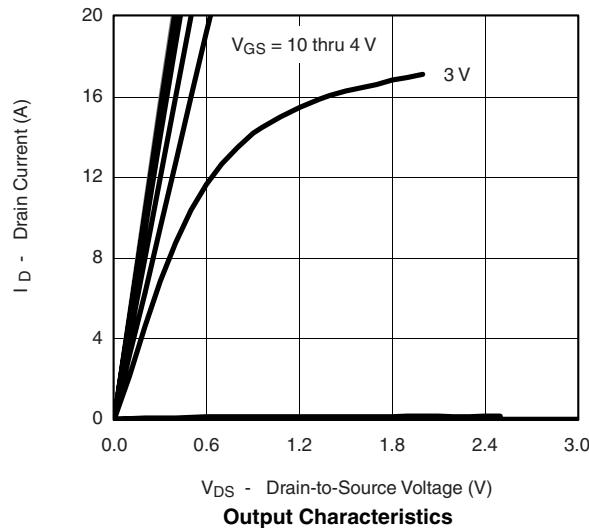
N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted


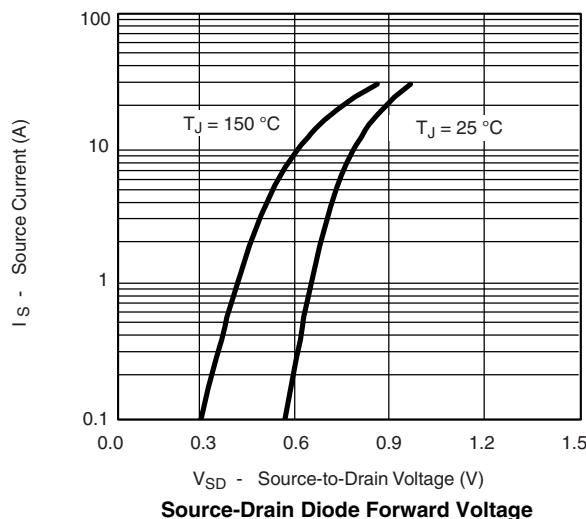
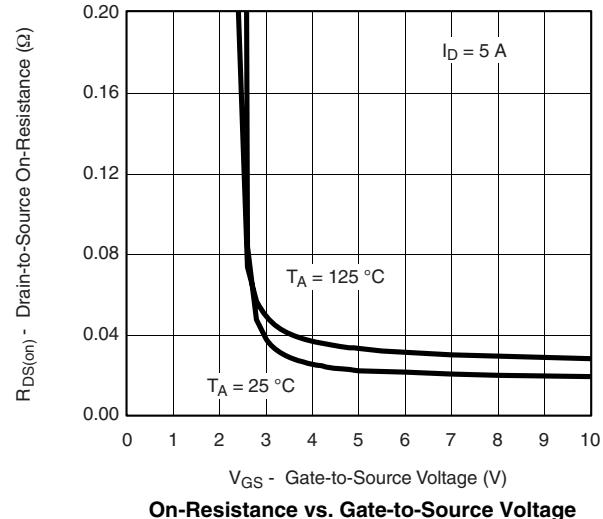
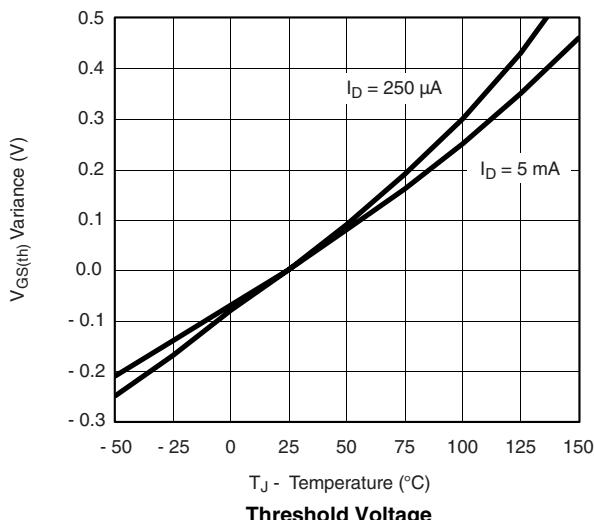
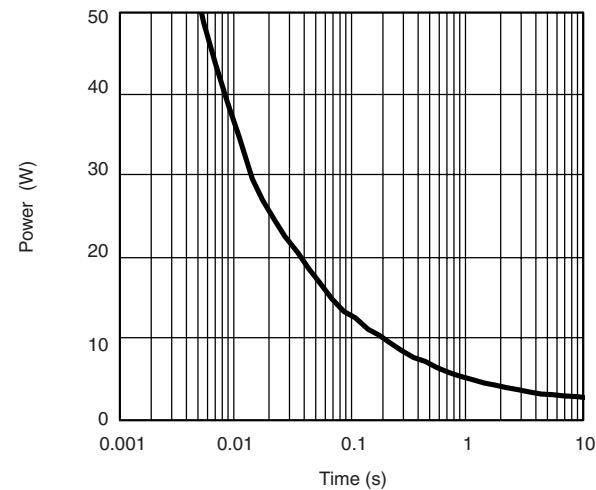
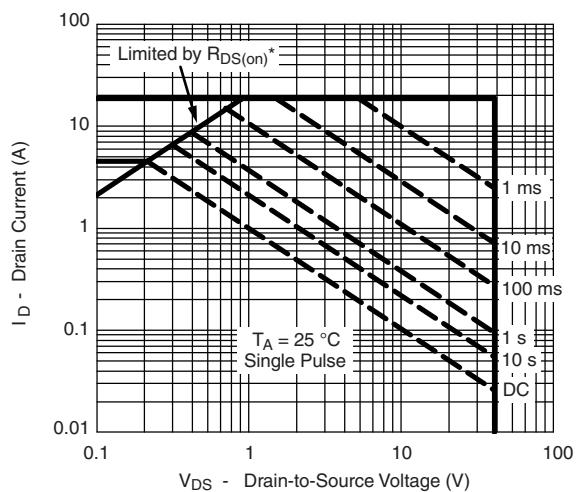
N-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted**Current Derating*****Power Derating, Junction-to-Foot****Power Derating, Junction-to-Ambient**

* The power dissipation P_D is based on $T_{J(\max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

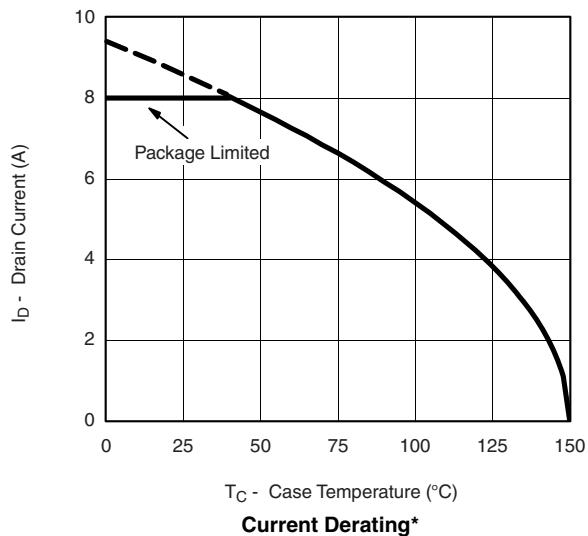
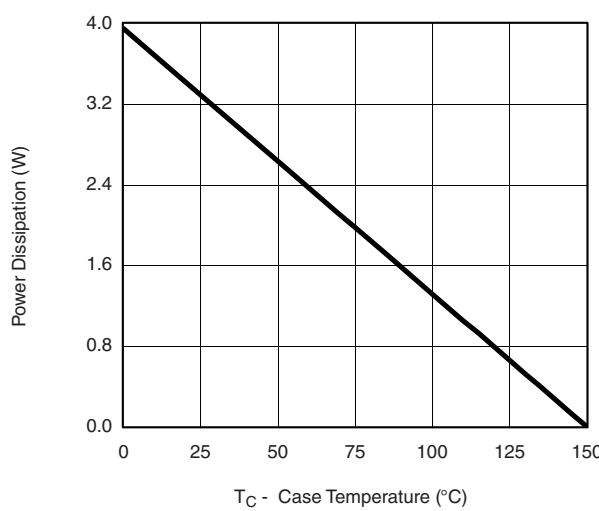
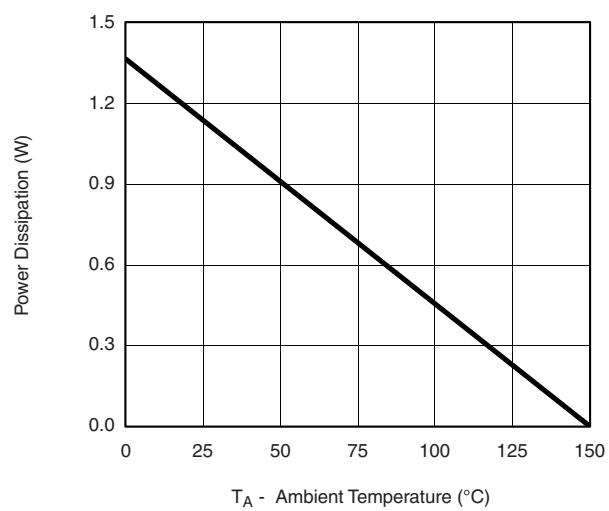
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P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

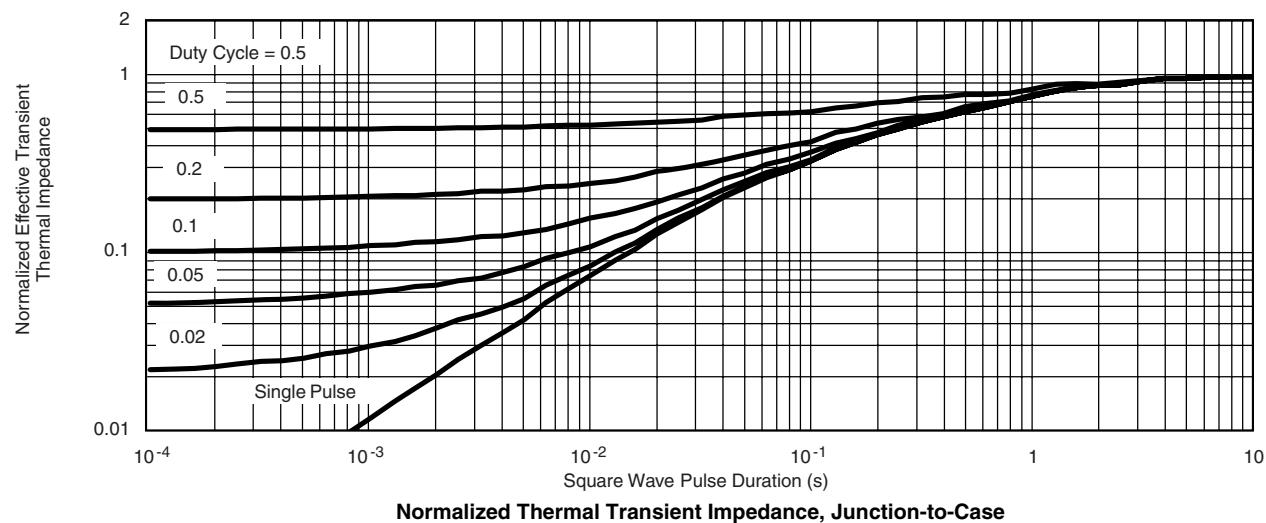
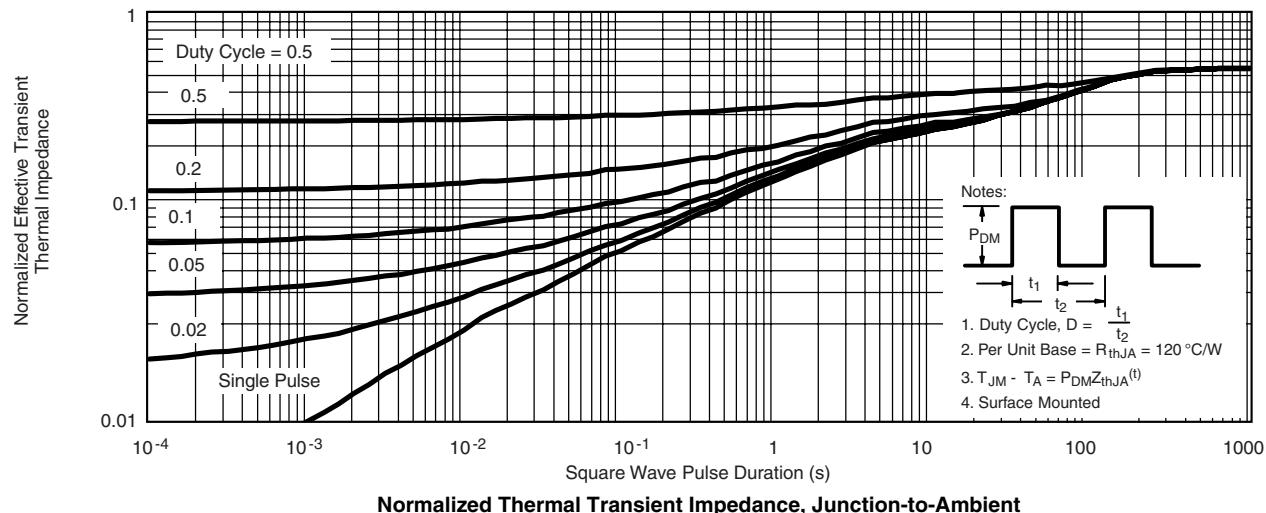


P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Source-Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage

Threshold Voltage

Single Pulse Power, Junction-to-Ambient

* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted
**Current Derating*****Power Derating, Junction-to-Foot****Power Derating, Junction-to-Ambient**

* The power dissipation P_D is based on $T_{J(\max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted


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